

April 1995 Revised August 1999

74FR2245

Octal Bidirectional Transceiver with 3-STATE Outputs

General Description

The 74FR2245 contains eight non-inverting bidirectional buffers with 3-STATE outputs and is intended for bus-oriented applications. Current sinking capability is 64 mA on the A Port. The Transmit/Receive (T/R) input determines the direction of data flow through the bidirectional transceiver. Transmit (active-HIGH) enables data from A Ports to B Ports; Receive (active-LOW) enables data from B Ports to A Ports. The Output Enable input, when HIGH, disables both A and B Ports by placing them in a High Z condition.

Features

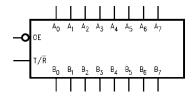
- Non-inverting buffers
- Bidirectional data path
- Guaranteed pin-to-pin skew
- \blacksquare 25 Ω series resistors in B outputs eliminate the need for external resistors
- 3-STATE outputs drive bus lines or buffer memory address resistors

Ordering Code:

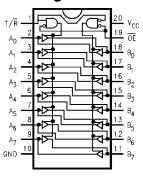
C	order Number	Package Number	Package Description
74	FR2245SC	M20B	20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" letter to the ordering code.

Logic Symbol



Connection Diagram



Pin Descriptions

Pin Names	Description				
ŌĒ	Output Enable Input (Active-LOW)				
T/R	Transmit/Receive Input				
A ₀ -A ₇	Side A Inputs or 3-STATE Outputs				
B ₀ -B ₇	Side B Inputs or 3-STATE Outputs				

Truth Table

Inp	uts	Output				
ŌĒ	T/R					
L	L	Bus B Data to Bus A				
L H		Bus A Data to Bus B				
Н	Х	High Z State				

- H = HIGH Voltage Level
- L = LOW Voltage Level
- X = Immateria

74FR2245 **Logic Diagram**

Absolute Maximum Ratings(Note 1)

 $\begin{array}{ll} \mbox{Storage Temperature} & -65^{\circ}\mbox{C to } +150^{\circ}\mbox{C} \\ \mbox{Ambient Temperature under Bias} & -55^{\circ}\mbox{C to } +125^{\circ}\mbox{C} \\ \end{array}$

 $\begin{array}{lll} \mbox{Junction Temperature under Bias} & -55^{\circ}\mbox{C to } +150^{\circ}\mbox{C} \\ \mbox{V}_{\mbox{CC}} \mbox{ Pin Potential to Ground Pin} & -0.5\mbox{V to } +7.0\mbox{V} \\ \end{array}$

 $\begin{array}{ll} \mbox{Input Voltage (Note 2)} & -0.5 \mbox{V to } +7.0 \mbox{V} \\ \mbox{Input Current (Note 2)} & -30 \mbox{ mA to } +5.0 \mbox{ mA} \\ \end{array}$

Voltage Applied to Output in HIGH State (with V_{CC} = 0V)

 $\begin{array}{ll} \text{Standard Output} & -0.5 \text{V to V}_{\text{CC}} \\ \text{3-STATE Output} & -0.5 \text{V to +5.5 V} \end{array}$

Current Applied to Output

in LOW State (Max) ${\rm twice\ the\ rated\ I_{OL}\ (mA)}$ ESD Last Passing Voltage (Min) ${\rm 4000V}$

Recommended Operating Conditions

Free Air Ambient Temperature 0° C to $+70^{\circ}$ C Supply Voltage +4.5V to +5.5V

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

DC Electrical Characteristics

Symbol	Parameter	Min	Тур	Max	Units	v _{cc}	Conditions
V _{IH}	Input HIGH Voltage	2.0			V		Recognized HIGH Signal
V _{IL}	Input LOW Voltage			0.8	V		Recognized LOW Signal
V _{CD}	Input Clamp Diode Voltage			-1.2	V	Min	$I_{IN} = -18 \text{ mA}$
V _{OH}	Output HIGH Voltage	2.4			V	Min	$I_{OH} = -3 \text{ mA } (A_n, B_n)$
		2.0			V	Min	$I_{OH} = -15 \text{ mA } (A_n, B_n)$
V _{OL}	Output LOW Voltage			0.5	V	Max	$I_{OL} = 1 \text{ mA } (B_n)$
				0.75	V	Max	$I_{OL} = 12 \text{ mA } (B_n)$
				0.55	V	Max	$I_{OL} = 64 \text{ mA } (A_n)$
I _{IH}	Input HIGH Current			5	μА	Max	$V_{IN} = 2.7V (\overline{OE}, T/\overline{R})$
I _{BVI}	Input HIGH Current Breakdown Test			7	μА	Max	$V_{IN} = 7.0V (\overline{OE}, T/\overline{R})$
I _{BVIT}	Input HIGH Current Breakdown Test (I/O)			100	μА	Max	$V_{IN} = 5.5V (A_n, B_n)$
I _{IL}	Input LOW Current			-250	μА	Max	$V_{IN} = 0.5V (\overline{OE}, T/\overline{R})$
V _{ID}	Input Leakage Test	4.75			V	0.0	I _{ID} = 1.9 μA All Other Pins Grounded
I _{OD}	Output Circuit Leakage Current			3.75	μА	0.0	V _{IOD} = 150 mV All Other Pins Grounded
I _{IH} + I _{OZH}	Output Leakage Current			25	μΑ	Max	$V_{OUT} = 2.7V (A_n, B_n)$
I _{IL} + I _{OZL}	Output Leakage Current			-150	μΑ	Max	$V_{OUT} = 0.5V (A_n, B_n)$
Ios	Output Short-Circuit Current	-100		-225	mA	Max	$V_{OUT} = 0.0V (A_n, B_n)$
I _{CEX}	Output HIGH Leakage Current			50	μΑ	Max	$V_{OUT} = V_{CC} (A_n, B_n)$
I _{ZZ}	Bus Drainage Test			100	μΑ	0.0	$V_{OUT} = 5.25V (A_n, B_n)$
I _{CCH}	Power Supply Current		55	75	mA	Max	All Outputs HIGH
I _{CCL}	Power Supply Current		75	110	mA	Max	All Outputs LOW
I _{CCZ}	Power Supply Current		55	75	mA	Max	Outputs 3-STATE
C _{IN}	Input Capacitance		8.0		pF	5.0	OE, T/R
			17.0		pF	5.0	A _n , B _n

AC Electrical Characteristics

Symbol	Parameter	$T_A = +25^{\circ}$ C $V_{CC} = +5.0$ V $C_L = 50 \text{ pF}$			$T_A = 0$ °C to +70°C $V_{CC} = +5.0V$ $C_L = 50 \text{ pF}$		Units
		Min	Тур	Max	Min	Max	
t _{PLH}	Propagation Delay	1.0		4.4	1.0	4.4	ns
t _{PHL}	A _n to B _n or B _n to A _n	1.0		4.4	1.0	4.4	115
t _{PZH}	Output Enable Time	2.5		7.5	2.5	7.5	ns
t _{PZL}		2.5		7.5	2.5	7.5	115
t _{PHZ}	Output Disable Time	1.7		6.5	1.7	6.5	ns
t _{PLZ}		1.7		6.5	1.7	6.5	115

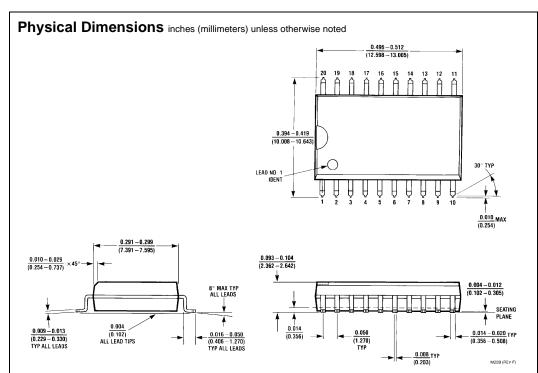
Extended AC Electrical Characteristics

Symbol	Parameter	T _A = 0°C	to +70°C	$T_A = 0^{\circ}C$ to $+70^{\circ}C$ $V_{CC} = +5.0V$ $C_L = 250 \text{ pF}$ (Note 4)		Units
		V _{CC} =	= + 5.0V			
		C _L =	50 pF			
		Eight Outpu	uts Switching			
		(No	ote 3)			
		Min	Max	Min	Max	Ì
t _{PLH}	Propagation Delay	1.0	7.0	2.5	10.0	ns
t _{PHL}	A_n to B_n or B_n to A_n	1.0	7.0	2.5	10.0	115
t _{PZH}	Output Enable Time	2.5	10.0			ns
t _{PZL}		2.5	10.0			113
t _{PHZ}	Output Disable Time	1.3	6.5			ns
t _{PLZ}		1.3	6.5			115
toshl	Pin-to-Pin Skew		1.7	1.7		ns
(Note 5)	for HL Transitions		1.7			
t _{OSLH}	Pin-to-Pin Skew		1.0			ns
(Note 5)	for LH Transitions	1.0				115
t _{OST}	Pin-to-Pin Skew		3.3			ns
(Note 5)	for HL/LH Transitions	3.3				115

Note 3: This specification is guaranteed but not tested. The limits apply to propagation delays for all paths described switching in phase, i.e., all LOW-to-HIGH, HIGH-to-LOW, 3-STATE-to-HIGH, etc.

Note 4: These specifications guaranteed but not tested. The limits represent propagation delays with 250 pF load capacitors in place of the 50 pF load capacitors in the standard AC load. This specification pertains to single output switching only.

Note 5: Skew is defined as the absolute value of the difference between the actual propagation delays for any two outputs of the same device. The specification applies to any outputs switching HIGH-to-LOW (t_{OSHL}), LOW-to-HIGH (t_{OSLH}), or HIGH-to-LOW and/or LOW-to-HIGH (t_{OST}). Specifications guaranteed with all outputs switching in phase.



20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide Package Number M20B

Fairchild does not assume any responsibility for use of any circuitry described, no circuit patent licenses are implied and Fairchild reserves the right at any time without notice to change said circuitry and specifications.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF THE PRESIDENT OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

- Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
- A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

www.fairchildsemi.com

This datasheet has been download from:

www.datasheetcatalog.com

Datasheets for electronics components.